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## The mechanism of enhanced photocatalytic activity for water-splitting of $\text{ReS}_2$ by strain and electric field engineering†

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To enhance the photocatalytic water splitting performance of 2D  $\text{ReS}_2$ , we theoretically propose a feasible strategy to engineer its band structure by applying strain or an electric field. Our calculated results show that the strains greatly tune the electronic structure of  $\text{ReS}_2$  especially band gap and band edge positions, because the strains significantly alter the crystal structure and then cause rearrangement of the surface charge. However, electric fields have little influence on band gap but obviously affect the band edge positions. This is because the electric fields have little effect on the crystal structure of  $\text{ReS}_2$  but easily produce an in-plane electric dipole moment. The shifts in band edge position mainly arise from competition between the surface charge and the in-plane electric dipole. For an applied strain, the shifts are dominated by rearrangement of surface charge; for an applied electric field, the shifts are determined by an induced electric dipole moment. Importantly, functionalized  $\text{ReS}_2$  with a bi-axial strain of  $-4\%$  or an electronic field of  $-0.1 \text{ V } \text{\AA}^{-1}$  may be good candidates for water-splitting photocatalysts owing to their suitable band edge positions for water splitting, ideal band gaps, good stability, reduced electron–hole recombination and high carrier mobility. We hope our findings will stimulate experimental efforts to develop new photocatalysts based on functionalized  $\text{ReS}_2$ .

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### 1. Introduction

Photocatalytic water splitting using solar energy for hydrogen generation is a clean and “green” approach to solving environmental and energy problems.<sup>1–12</sup> Efficient semiconductor photocatalysts for water splitting should satisfy the following requirements: (1) an ideal band gap for wide visible-light adsorption; (2) suitable band edge positions which should straddle water redox potentials; (3) fewer electron–hole pair recombination; (4) high carrier mobility; and (5) good stability.<sup>13–16</sup> Traditional photocatalysts such as  $\text{TiO}_2$ ,<sup>17,18</sup>  $\text{ZnO}$ ,<sup>19,20</sup> and  $\text{KNbO}_3$  have been reported to be promising photocatalysts.<sup>21,22</sup> Nevertheless, their large band gaps greatly limit their visible-light absorption and result in poor photo-to-hydrogen conversion efficiency.

Since graphene was first prepared, two-dimensional (2D) transition-metal materials have shown efficient photocatalytic properties because of their good surface to volume ratio, abundant chemically active sites, and low charge carrier diffusion distance.<sup>23–28</sup> 2D transition-metal dichalcogenides (TMDs),<sup>29–32</sup> as represented by  $\text{MoS}_2$ , have a direct band gap,

strong visible-light absorption, excellent stability, and high electrocatalytic activity, so they are potential candidates for electronic, optoelectronic, and photovoltaic applications.<sup>33–35</sup> Different from the traditional TMDs (e.g.,  $\text{MoS}_2$  and  $\text{WS}_2$ ),  $\text{ReS}_2$  has a triclinic symmetry and displays a distorted 1T (1T') octahedral crystal structure, showing a particular electronic and optical anisotropy with a high experimental anisotropic mobility ratio of 3.1.<sup>36–40</sup> The electronic and dynamic decoupling in the interface with weak van der Waals forces enable it to retain a direct band gap ( $\sim 1.5 \text{ eV}$ ) almost independent of thickness.<sup>41</sup> The weak coupling enables  $\text{ReS}_2$  to be easily prepared as nanosheets, exhibiting excellent Raman active modes and catalytic activity in the hydrogen evolution reaction.<sup>42</sup> These advantages make  $\text{ReS}_2$  a potential candidate for photocatalytic water splitting.<sup>13</sup> However, the conduction band minimum (CBM) of  $\text{ReS}_2$  is below the hydrogen redox potential of water, hindering its application in photocatalytic hydrogen generation.<sup>43,44</sup> Therefore, it is necessary to tune the band energy alignment of  $\text{ReS}_2$  to enhance its photocatalytic activity for water splitting. In particular, mechanical strain or an external electric field are effective and practical ways to adjust the electronic properties of a 2D semiconductor.<sup>45–52</sup> For example, Bai *et al.* have shown that single-layer  $\text{ZnGeN}_2$  could be effectively tuned to provide a better match with the redox potentials of water and to enhance light absorption in the visible-light region at a tensile strain of 5%.<sup>49</sup> Edalati *et al.* suggested that  $\text{CsTaO}_3$  and  $\text{LiTaO}_3$  exhibited optical bandgap

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narrowing and  $\sim 2.5$  times enhancement of photocatalytic hydrogen generation by straining.<sup>50</sup> Wang *et al.* reported that the biaxial strain tuned the bandgap and band alignment of a 2D CdS/g-C<sub>3</sub>N<sub>4</sub> heterostructure for visible-light photocatalytic water splitting and accelerated the separation of photogenerated carriers and improved the photocatalytic activity.<sup>51</sup> Dai *et al.* have described the ferroelectric photocatalysts could be greatly improved because the intrinsic internal electric field was beneficial for separation and migration of photogenerated carriers.<sup>52</sup>

In this work, we investigate the potential of 2D ReS<sub>2</sub> for photocatalytic water splitting by strain and electric field functionalization. The first-principles calculations show that the strains greatly engineer the band gap and band alignment of ReS<sub>2</sub>. A progressive shrinking in the band gap can be observed upon increasing the applied strain for both tensile and compressive strain, and for both axial and bi-axial strain. This is because the strains induce significant geometric distortion and lead to charge rearrangement. Although the band gap of ReS<sub>2</sub> is insensitive to an electric field, the band alignment depends greatly on an electric field because the electric field has little influence on the crystal structure but can produce an in-plane dipole moment. As a result, functionalized ReS<sub>2</sub> with a bi-axial strain of  $-4\%$  or an electronic field of  $-0.1$  V Å<sup>-1</sup> are considered good candidates for water-splitting photocatalysts.

## 2. Computational model and methods

In our calculations, density functional theory (DFT) were adopted with the Vienna *ab initio* simulation package (VASP).<sup>53</sup> The exchange correlation potential was the generalized gradient approximation (GGA) with Perdew–Burke–Ernzerhof (PBE).<sup>54,55</sup> The frozen core projector augmented wave method was employed to describe the electron–ion interaction. The plane wave cutoff energy was 400 eV, the total change in energy for geometrical optimization was  $1.0 \times 10^{-5}$  eV, the atomic forces were less than 0.01 eV Å<sup>-1</sup>.  $7 \times 7 \times 1$  and  $11 \times 11 \times 1$  Monkhorst–Pack *k*-point mesh were respectively used for geometric optimization and the electronic structure calculations.

As we know, monolayer ReS<sub>2</sub> has almost the same electronic structure as multilayer ReS<sub>2</sub>.<sup>41</sup> Thus, a  $2 \times 2$  supercell of free-standing monolayer ReS<sub>2</sub> was used as our model by cleaving the bulk ReS<sub>2</sub> along (0001) direction. A vacuum space along the *y*-direction was 15 Å to separate the interactions between the neighbouring slabs. As shown in Fig. 1, uniaxial lattice strain (*x*-axial or *z*-axial) was imposed by changing the dimension of the supercell in the *x*- or *z*-directions. Bi-axial lattice strain was imposed by changing the dimension of the supercell in the *x*- and *z*-directions simultaneously. We calculated the percentage applied strain according to % strain =  $(a - a_0)/a \times 100\%$ , where *a* and *a*<sub>0</sub> are the lattice constants of the ReS<sub>2</sub> monolayer before and after the application of strain. The strains were varied from  $-10\%$  to  $10\%$  in steps of  $2\%$ , where the positive numbers represent tensile strains, and the negative numbers represent compressive strains. The positions of all the atoms in the supercell were fully relaxed but the lattice vectors were constrained. An external electric field intensity

*E*<sub>⊥</sub> was applied along the *y*-direction with a net electric-dipole moment, from  $-0.2$  V Å<sup>-1</sup> to  $0.2$  V Å<sup>-1</sup> in steps of  $0.05$  V Å<sup>-1</sup>. Dipole corrections were applied to remove spurious dipole interactions between periodic images.<sup>56,57</sup>

## 3. Results and discussion

### 3.1 Pristine ReS<sub>2</sub> monolayer

As shown in Fig. 1(a), the monolayer ReS<sub>2</sub> retains a triclinic structure. The bond distances *d*<sub>Re-Re</sub>, *d*<sub>Re<sub>2</sub>-S<sub>2</sub></sub>, *d*<sub>Re<sub>2</sub>-S<sub>3</sub></sub>, and *d*<sub>S-S</sub> are 2.717 Å, 2.359 Å, 2.432 Å, and 3.807 Å, respectively. The bond angles of Re<sub>1</sub>-S<sub>2</sub>-Re<sub>2</sub>, S<sub>2</sub>-Re<sub>2</sub>-S<sub>2</sub>, and S<sub>1</sub>-Re<sub>2</sub>-S<sub>3</sub> are defined as  $\theta_1$ ,  $\theta_2$ , and  $\theta_3$  with values 70.2°, 105.2°, and 80.9°, which are consistent with the experimental values (*d*<sub>Re-Re</sub> = 2.722 Å, *d*<sub>Re<sub>2</sub>-S<sub>2</sub></sub> = 2.360 Å, *d*<sub>Re<sub>2</sub>-S<sub>3</sub></sub> = 2.434 Å, *d*<sub>S-S</sub> = 3.806 Å,  $\theta_1$  = 70.3°,  $\theta_2$  = 105.1°, and  $\theta_3$  = 81.1°).

The band structure of ReS<sub>2</sub> was reported in our previous calculation.<sup>29</sup> ML-ReS<sub>2</sub> is a direct-band-gap semiconductor, both the valence band maximum (VBM) and the conduction band minimum (CBM) are located at the  $\Gamma$  point, with a calculated band gap of 1.431 eV. Analysis of the partial density of states (PDOS) shows that the VBM originates mainly from hybridization among S-3p<sub>x</sub>, Re-5d<sub>yz</sub>, and Re-5d<sub>xz</sub> orbitals; the CBM consists mainly of S-3p<sub>z</sub> and Re-5d<sub>xz</sub> and Re-5d<sub>z<sup>2</sup></sub> [see PDOS in Fig. 1(c)]. Though the VBM is below the water oxidation level, the CBM is located below the hydrogen redox potential [see Fig. 1(d)], the photocatalytic activity of hydrogen production in ReS<sub>2</sub> is inhibited. These calculated results are in good agreement with the experimental results.<sup>44</sup>

### 3.2 Tuning band edge positions to improve the photocatalytic performance of ReS<sub>2</sub> through applying uniaxial or bi-axial strain

**3.2.1 Stability.** It is found that the in-plane strains greatly influence not only the in-plane Re-S (*d*<sub>Re-S</sub>) and Re-Re bond (*d*<sub>Re-Re</sub>) lengths but also the vertical distance between the S atoms *d*<sub>S-S</sub> (within an S-Re-S sheet) and S-Re-S bond angle.

As shown in Fig. 2, tensile strains, whether uniaxial or bi-axial, elongate the in-plane bond lengths, but slightly shorten the vertical S-S distance because the lattice vectors in the plane are fixed in the process of atomic relaxation. Compressive strains produce the opposite effect. Here *d*<sub>Re<sub>2</sub>-S<sub>3</sub></sub> increases with an increase in *x*-axial strain, while it is almost unchanged with an increase in *z*-axial strain because there are no components of *d*<sub>Re<sub>2</sub>-S<sub>3</sub></sub> in the *z*-direction. Similarly, *d*<sub>Re<sub>2</sub>-S<sub>2</sub></sub> and *d*<sub>Re-Re</sub> increase with an increase in *z*-axial strain, while they are almost unchanged with an increase in *x*-axial strain because there are no components of *d*<sub>Re-Re</sub> in the *z*-direction. As far as bond angle is concerned, the opposite sides of  $\theta_1$  and  $\theta_3$  are Re<sub>1</sub>-Re<sub>2</sub> and S<sub>1</sub>-S<sub>3</sub>, respectively, which being parallel to *z*-axial and *x*-axial strains, will be elongated by tensile strains. Thus,  $\theta_1$  increases with an increase in *z*-axial strain and  $\theta_3$  increases with an increase in *x*-axial strain. The influence of bi-axial strain is found to be more pronounced than that of uniaxial strains because it comes from the common effect of *x*-axial and *z*-axial strains.



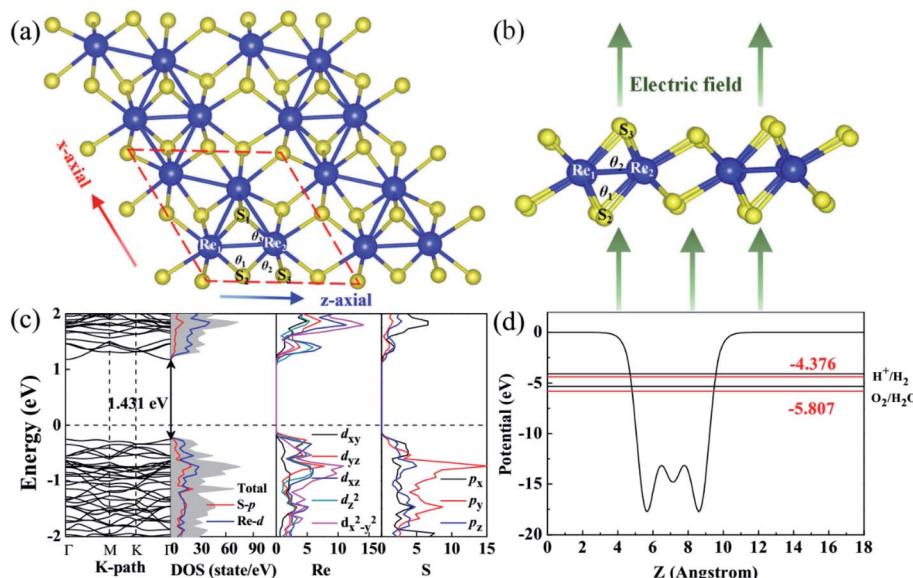


Fig. 1 (a) Top and (b) side views of ML-ReS<sub>2</sub>; the blue and red arrows represent the directions of applied strain and the green arrows represent the direction of the electric field. (c) Band structure and atom-PDOS of ML-ReS<sub>2</sub>. (d) Work-function of ML-ReS<sub>2</sub> (red line) and band alignments (denoting by the red solid lines) relative to the water redox potential positions (denoting by the black lines).

To further investigate the stability of ReS<sub>2</sub>, we calculated its formation energy, which is defined as:<sup>46</sup>  $E_f = E_{2D}/N_{2D} - E_{3D}/N_{3D}$ , where  $E_{2D}$  and  $E_{3D}$  are the total energy of monolayer and bulk ReS<sub>2</sub>, and  $N_{2D}$  and  $N_{3D}$  are the number of atoms in monolayer

and bulk ReS<sub>2</sub>. The formation energies of *x*-axial-strained ReS<sub>2</sub> decrease with an increase in the strains and the decrease is sharper under compressive strains than under tensile strains. Additionally, all the formation energies have negative values

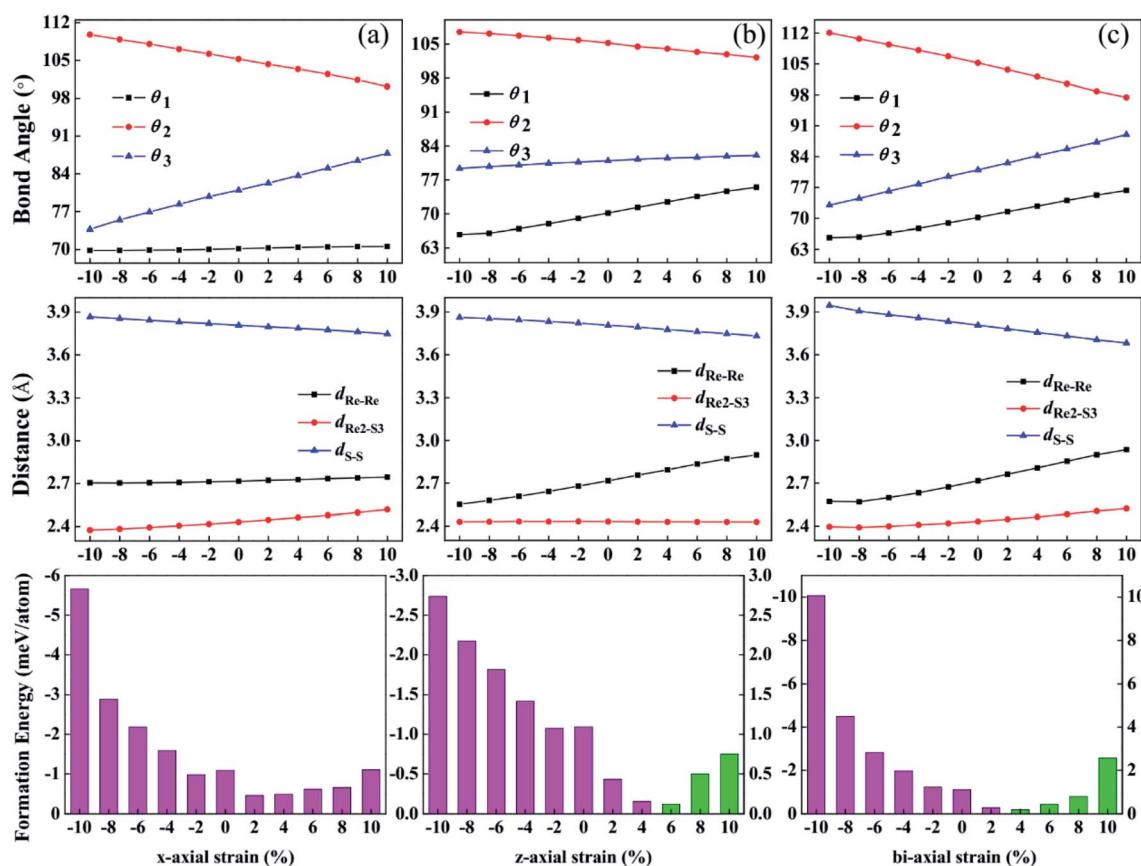


Fig. 2 The calculated structural parameters and formation energies of ReS<sub>2</sub> as a function of (a) *x*-axial, (b) *z*-axial and (c) bi-axial strain.

and are smaller than that of pristine  $\text{ReS}_2$ , indicating that monolayer  $\text{ReS}_2$  is stable. For  $z$ -axial and bi-axial strains, the formation energies decrease with an increase in the compressive strains but increase with an increase in the tensile strains, indicating that the systems are more stable under compressive strains than under tensile strains.

**3.2.2 Electronic structures.** The structural change has a significant impact on the electronic structure of strained  $\text{ReS}_2$ . Under compressive strain, localized states appear at the bottom of the valence band, originating from  $\text{Re}-5\text{d}_{xz}$  and  $\text{S}-3\text{p}_x$  states, and the energy of the CBM decreases. Meanwhile, the CBM changes from the  $\Gamma$  point to the K point, the VBM transfers from the  $\Gamma$  point to the M point then to the K point, and as a result  $\text{ReS}_2$  becomes an indirect-band-gap semiconductor and the band gap decreases with the increase in compressive strain [see Fig. 3(a)–(d)]. Under  $x$ -axial tensile strains, the systems still display direct-band-gap semiconductor properties, as shown in Fig. 3(f)–(i). More particularly, the tensile strain little affects the CBM, while it causes a decrease in the energy at the VBM, induced by a reduction in the distance between the S atoms ( $d_{\text{S-S}}$ ) and an increase in the distance between the Re and S atoms ( $d_{\text{Re-S}}$ ). The  $5\text{d}_{x^2-y^2}$  of the Re atoms gradually has a great effect on the CBM; therefore the band gap decreases from 1.431 to 0.540 eV when the applied tensile strain changes from 0 to 10%.

For  $z$ -axial compressive strained  $\text{ReS}_2$ , the energy of the CBM decreases with an increase in the compressive strain, thus, the band gap decreases from 1.431 to 0.688 eV when the compressive strain varies from 0 to  $-10\%$  [see Fig. S1(a)–(d) in the ESI<sup>†</sup>].<sup>42</sup> Under  $z$ -axial tensile strain,  $\text{ReS}_2$  changes to indirect-

band-gap semiconductor, the VBM locates at the  $\Gamma$  point but its energy decreases, while the CBM relocates from the  $\Gamma$  point to the M point and then to the K point. The PDOS in Fig. S1(f)–(i)<sup>†</sup> indicates that the  $\text{Re}-5\text{d}_{xz}$  states and  $\text{S}-3\text{p}_y$  states play important roles in the process. This is mainly induced by the changes in  $d_{\text{S-S}}$  and  $d_{\text{Re-Re}}$ . Thus, the band gap decreases from 1.431 eV to 0.783 eV as the tensile strains vary from 0 to 10%.

The effect of the bi-axial strain on  $\text{ReS}_2$  is the result of the common effect of  $x$ -axial and  $z$ -axial strain on  $\text{ReS}_2$ . Thus, bi-axial-strained  $\text{ReS}_2$  is an indirect-band-gap semiconductor and the band gap decreases (from 1.431 eV to 0.452 eV) with an increase in the strains, whether compressive or tensile.  $\text{ReS}_2$  displays metallic properties at 10% bi-axial compressive strain as there are a few bands across the Fermi level which mainly originate from hybridization of  $\text{Re}-5\text{d}_{x^2-y^2}$ ,  $5\text{d}_{xz}$ , and  $\text{S}-3\text{p}_x$ . Clearly, for the bi-axial compressive strain,  $\text{Re}-5\text{d}_{xz}$  and  $\text{S}-3\text{p}_x$  play a leading role near the Fermi level. While for the bi-axial tensile strain,  $\text{Re}-5\text{d}_{x^2-y^2}$  and  $\text{S}-3\text{p}_y$  play important roles near the Fermi level [see Fig. S2<sup>†</sup>].

**3.2.3 The band edge positions of strained  $\text{ReS}_2$  for photocatalytic water splitting.** The redox potentials at  $\text{pH} = 7$ , which is the solution condition for VASP calculation, are  $-5.26$  eV for water-oxidation potential ( $\text{O}_2/\text{H}_2\text{O}$ ) and  $-4.03$  eV for the hydrogen reduction ( $\text{H}^+/\text{H}_2$ ).<sup>58</sup> Fig. 4 shows the band alignment of strained- $\text{ReS}_2$  related to water redox potentials at  $\text{pH} = 7$ . For  $x$ -axial strain, the CBM of  $\text{ReS}_2$  moves upward by 0.049–0.210 eV for compressive strain but downshifts by 0.076–0.701 eV for tensile strain compared to pristine  $\text{ReS}_2$ . A similar phenomenon occurs under  $z$ -axial and bi-axial strains. According to Bader

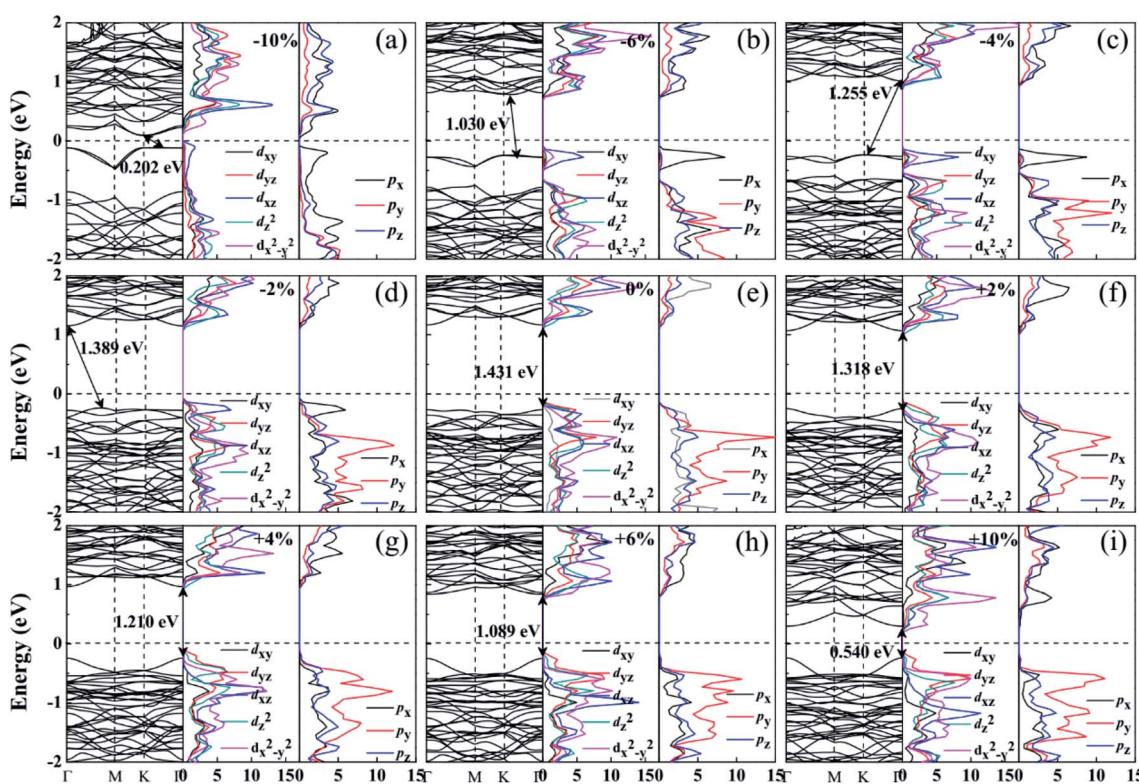


Fig. 3 Band structure and PDOS of ML- $\text{ReS}_2$  at  $x$ -axial strains of (a)  $-10\%$ , (b)  $-6\%$ , (c)  $-4\%$ , (d)  $-2\%$ , (e)  $0\%$ , (f)  $2\%$ , (g)  $4\%$ , (h)  $6\%$  and (i)  $10\%$ .





Fig. 4 Calculated band alignments and band gaps of ReS<sub>2</sub> at different (a) x-axial, (b) z-axial and (c) bi-axial strains in comparison with water redox potentials.

charge analysis, we find there is charge transfer inside the strained ReS<sub>2</sub>.<sup>59</sup> For the compressive strains, ReS<sub>2</sub> gains electrons (for example, ReS<sub>2</sub> gains 0.022e with a compressive x-axial strain of -2%), the Fermi energy level increases, and the band edge positions upshifts. This is because the crystal structure becomes compact under compressive strain, and the surface charge distribution is relatively concentrated. Conversely, for tensile strains, ReS<sub>2</sub> loses electrons (for example, ReS<sub>2</sub> loses 0.005e with a tensile x-axial strain of 2%), the Fermi energy reduces, the band edge position downshifts, because the crystal structure becomes looser under tensile strain, and the surface charge distribution is relatively scattered.

As we know, the work function is greatly determined by the crystal structure which is related to the surface charge distribution and the electron surface barrier caused by an internal electron field related to the surface electric dipole distribution. There is competition between the surface charge and the surface electric dipole. The in-plane strains cause severe distortion of the crystal structure, then influence the surface charge distribution, and thus decisively affect the work function. However, the in-plane strain induces little geometric distortion in the vertical direction, therefore inducing a very small dipole moment perpendicular to the surface component  $\mu_{\perp}$ ,<sup>60</sup> and then slightly affecting the work function. For example, for ReS<sub>2</sub> with a bi-axial strain of -4%, the induced

dipole density  $\mu_{\perp}$  is only -0.006 D nm<sup>-2</sup> [see the Table S1 in the ESI†],<sup>42</sup> little affecting the work function. Thus, the strain-induced rearrangement of surface charge plays an important role, leading to a great change in the work function of -0.382 eV. According to  $\Delta V_{\perp} = -\Delta W_{\perp}$ , where  $\Delta V_{\perp}$  and  $\Delta W_{\perp}$  respectively refer to the band edge shifts and the opposite direction. The band edge position upshifts by 0.382 eV [see the Table in the ESI†].<sup>42</sup> As a result, the CBM of ReS<sub>2</sub> straddles the water reduction potential, and ReS<sub>2</sub> satisfies the demands of water splitting.

### 3.3 Tuning band edge positions to improve the photocatalytic performance of ReS<sub>2</sub> through applying an electric field

We further attempted to tune the band structure of ReS<sub>2</sub> by applying an electric field. The vertical electric fields are applied with different intensities along the y-direction. Fig. 5(a) shows that the formation energies of ReS<sub>2</sub>, defined as  $E_f = E_{2D}/N_{2D} - E_{3D}/N_{3D}$ ,<sup>46</sup> have negative values, indicating that the systems have good stability under different vertical electric fields.

Fig. 6 displays the electronic structures of ReS<sub>2</sub> under different external electric fields. ReS<sub>2</sub> maintaining direct-bandgap semiconductor properties. For a positive electric field, the Re-5d and S-3p components of the CBM are slightly enlarged



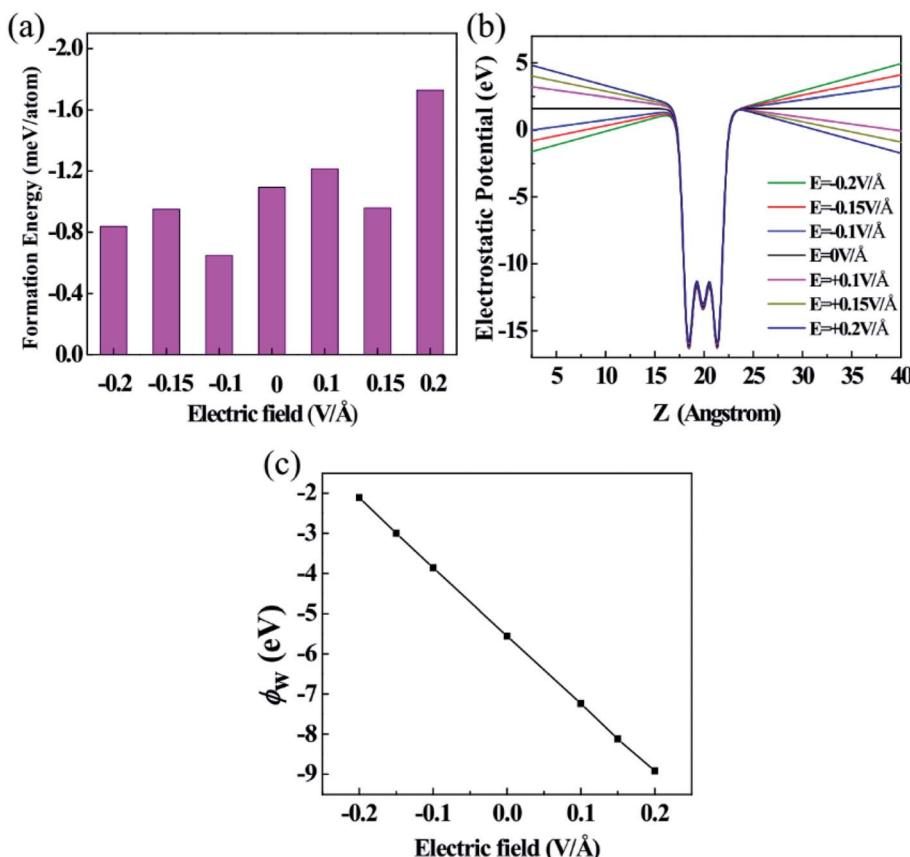


Fig. 5 (a) Formation energy, (b) average electrostatic potential and (c) work function of  $\text{ReS}_2$  under different electric fields.

[see Fig. 6(d)–(f)], for a negative electric field, the Re-5d component of the VBM is slightly enlarged [see Fig. 6(a)–(c)]. Thus the band gap decreases slightly with an increase in the electric fields, changing from 1.431 to 1.411 eV, and the minimum value of 1.411 eV is found under electric fields of  $-0.2 \text{ V} \text{ \AA}^{-1}$  and  $0.2 \text{ V} \text{ \AA}^{-1}$ .

Though the electric field has little influence on the band gap, it produces an in-plane dipole moment and then greatly affects the average electrostatic potential of  $\text{ReS}_2$ . As shown in the charge difference density in the inset of Fig. 7, surface charge transfer depends on the direction of  $E_{\perp}$ : for a negative electric field, the charge transfers from the upper side to the lower side,

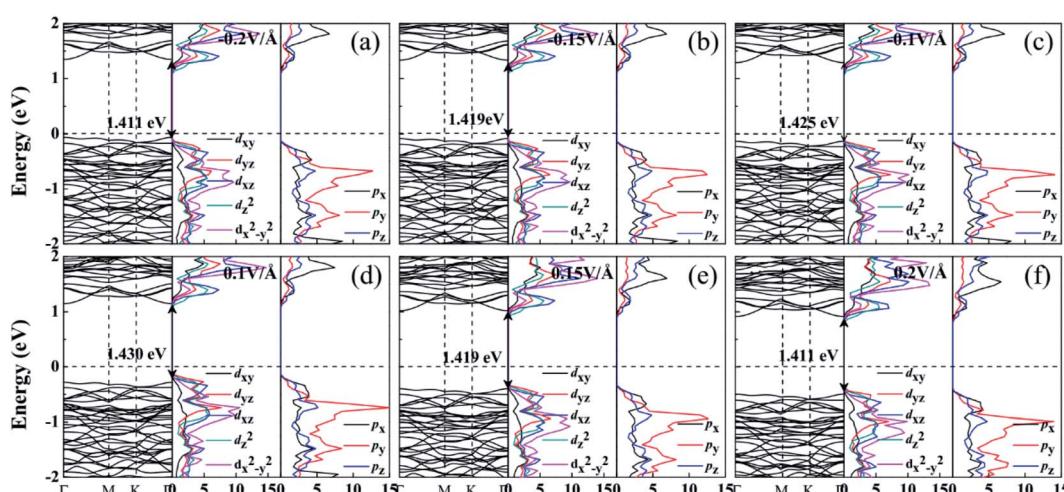


Fig. 6 Band structure and PDOS of ML- $\text{ReS}_2$  under vertical electric fields of (a)  $-0.2 \text{ V} \text{ \AA}^{-1}$ , (b)  $-0.15 \text{ V} \text{ \AA}^{-1}$ , (c)  $-0.1 \text{ V} \text{ \AA}^{-1}$ , (d)  $0.1 \text{ V} \text{ \AA}^{-1}$ , (e)  $0.15 \text{ V} \text{ \AA}^{-1}$  and (f)  $0.2 \text{ V} \text{ \AA}^{-1}$ .



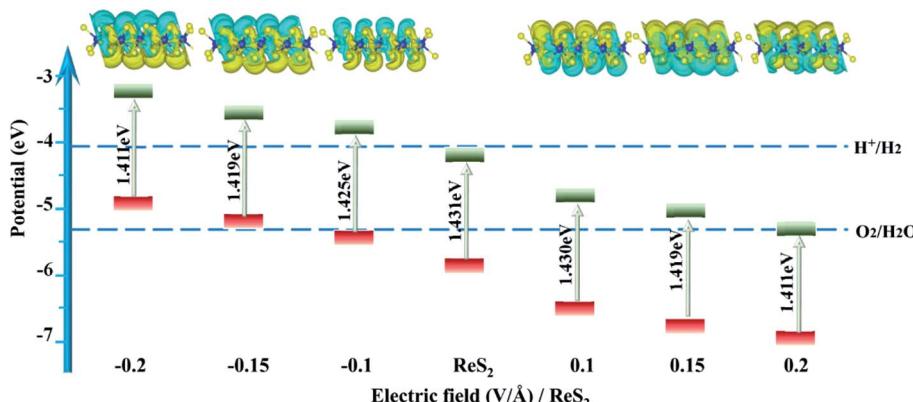


Fig. 7 The band alignments and band gaps of  $\text{ReS}_2$  at different external electric fields. The inset shows the charge density difference of  $\text{ReS}_2$ ; yellow and green colors represent charge accumulation and charge depletion, respectively. The isovalue is  $0.003 \text{ e} \text{\AA}^{-3}$ .

whereas, for a positive electric field, the charge transfers from the lower side to the upper side. The Bader charge analysis also quantitatively shows that there are  $0.036e$  charges transferred from the upper side to the lower side for  $E_{\perp} = -0.1 \text{ V} \text{\AA}^{-1}$ ,<sup>59</sup> there are  $0.143e$  charges transfer from the lower side to the upper side for  $E_{\perp} = 0.1 \text{ V} \text{\AA}^{-1}$ . Simultaneously, a vertical electric field alters the surface charge concentration of  $\text{ReS}_2$ . Fig. 5(b) shows the electrostatic potential  $\bar{V}(y)$  under different electric fields, which displays a sawtooth behavior. For a negative electric field,  $\bar{V}(y)$  increases linearly with an increasing vacuum layer, while the opposite is true for a positive field. Thus, the work function on both sides can be defined as  $W = mE_{\perp} + \Phi_w$ ,<sup>61,62</sup> where  $\Phi_w$  is the work function of  $\text{ReS}_2$  without the external electric field, and  $m$  is the slope of the line relating to vacuum lengths. Fig. 5(c) shows that the work function varies linearly with the electric field, and the change in work function ( $\Delta W_{\perp}$  arises from the electric-field-induced dipole density, expressed as  $\Delta W_{\perp} = \mu_{\perp}/A\epsilon_0$ , where  $A$  is the surface area per molecule,  $\epsilon_0$  is the dielectric constant of the vacuum). As shown in Table 1, when  $E_{\perp} = -0.1 \text{ V} \text{\AA}^{-1}$ , the induced dipole density is  $-1.382 \text{ D nm}^{-2}$ , and the resultant change in work function is  $0.521 \text{ eV}$ , which is in agreement with the energy shift calculated from the average electrostatic potential.

Fig. 7 shows the band edges of  $\text{ReS}_2$  with different electric fields.  $\text{ReS}_2$  obviously upshifts with increasing negative electric

fields, and the reduction capacity increases, while it downshifts with increasing positive electric fields, and the oxidation capacity increases. It is worth mentioning that the applied electric field can not only tune the band edge but also accelerate electron–hole separation and enhance activity carrier mobility. For  $\text{ReS}_2$  with an applied electric field of  $-0.1 \text{ V} \text{\AA}^{-1}$ , the band edge upshifts by  $0.521 \text{ eV}$  and straddles the water redox potential.

## 4. Conclusions

To summarize, based on DFT calculations, we applied an external strain or an electric field to engineer the electronic structure of  $\text{ReS}_2$  to meet the requirements of hydrogen production through photocatalytic water splitting. The in-plane strains have a great influence on the band gap and band alignment originating from great changes in the crystal structure. An increase in the strain decreases the band gap of  $\text{ReS}_2$ , and the band edge positions downshift with an increase in the tensile strains and upshift with an increase in compressive strains, where the shifts come mainly from rearrangement of surface charge. While the external electric fields slightly influence the band gap of  $\text{ReS}_2$  but greatly affect its band alignment. The band edge position shifts come from an external-electronic-field-induced dipole moment. Importantly,  $\text{ReS}_2$  with a bi-axial strain of  $-4\%$  or an electric field of  $-0.1 \text{ V} \text{\AA}^{-1}$  can be considered strong candidates for photocatalytic water splitting because they possess suitable band edge positions for water splitting, ideal band gaps for visible-light absorption, good stability, reduced electron–hole recombination, and high carrier mobility. Notably, applying strain or an electric field is a feasible means of functionalization of single-layered and multi-layered nanostructures for better photocatalytic water splitting.

Table 1 Vertical electric field  $E_{\perp}$  (in eV), electric-field-induced dipole density  $\mu_{\perp}/A$  (in  $\text{D nm}^{-2}$ ), change in work function  $\Delta W_{\perp}$  (in eV) of functionalized  $\text{ReS}_2$  relative to pure  $\text{ReS}_2$ , band gap  $E_g$  (in eV), VBM and CBM positions  $E_{\text{VBM}}$  and  $E_{\text{CBM}}$  (in eV), and the formation energy  $E_f$  (in meV) of  $\text{ReS}_2$  under different vertical electric fields

$E_{\perp}$	$\mu_{\perp}/A$	$\Delta W_{\perp}$	$E_g$	$E_{\text{VBM}}$	$E_{\text{CBM}}$	$E_f$
-0.2	-2.767	-1.043	1.411	-4.743	-3.332	-0.8
-0.15	-2.074	-0.782	1.419	-5.012	-3.593	-0.9
-0.1	-1.382	-0.521	1.425	-5.279	-3.854	-0.6
0	0	0	1.431	-5.807	-4.376	-1.1
0.1	1.389	0.523	1.430	-6.330	-4.900	-1.2
0.15	2.081	0.784	1.419	-6.580	-5.161	-0.9
0.2	2.777	1.047	1.411	-6.835	-5.424	-1.7

## Conflicts of interest

There are no conflicts to declare.

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